


<b>Search Notes</b>  	<b>Application/Control No.</b>  10528816	<b>Applicant(s)/Patent Under Reexamination</b>  NAKAI ET AL.
	<b>Examiner</b>  Trinh, Minh	<b>Art Unit</b>  3729

SEARCHED			
Class	Subclass	Date	Examiner
29	740-743, 759-762, 834, Dig.44	7/26/07	mt
414	737, 751.1, 752.1,		
901	40		
269	903		

SEARCH NOTES			
Search Notes		Date	Examiner
East Searched		7/26/07	mt

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner